


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,173	BENSON ET AL.	
	Examiner	Art Unit	
	Dah-Wei D. Yuan	1745	

SEARCHED			
Class	Subclass	Date	Examiner
429	122	7/19/2007	DWY
429	209	7/19/2007	DWY
429	241	7/19/2007	DWY

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	7/19/2007	DWY
STN	7/19/2007	DWY